

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/815,937	NAKATA, HIDEHIKO
	<b>Examiner</b>	<b>Art Unit</b>
	Thomas R. Hannon	3682

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPub text search, see printout	1/23/2006	TRH	